

RESPONSE UNDER 37 CFR 1.116 EXPEDITED PROCEDURE EXAMINING GROUP 2125

PATENT APPLICATION

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:)	
	:	Examiner: Ryan A. Jarrett
SHIGEYUKI UZAWA, ET AL.)	•
	:	Group Art Unit: 2125
Application No.: 09/864,309)	•
•	:	Confirmation No.: 2803
Filed: May 25, 2001)	
	:	
For: EXPOSURE APPARATUS, COATING/DEVELOPING)	
SYSTEM, DEVICE MANUFACTURING SYSTEM,	:	March 22, 2005
DEVICE MANUFACTURING METHOD,)	
SEMICONDUCTOR MANUFACTURING FACTORY,	:	Do not enter
AND EXPOSURE APPARATUS MAINTENANCE)	130 KOL EME.
METHOD	:	HININE
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Mail Stop AF		~ y
Commissioner for Patents		υ
P.O. Box 1450		

AMENDMENT AFTER FINAL REJECTION

Sir:

Alexandria, VA 22313-1450

Introductory Comments

In response to the final Official Action dated December 22, 2004, please amend the above-identified application as follows, pursuant to 37 C.F.R. § 1.116: